



17. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: ZNFAS110	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT	 LG	Approved by: Quality Manager
Filename: 1M1701230039-07.ZNF	Test Dates: 01/23/2017 - 01/25/2017	DUT Type: Portable Handset	Page 64 of 66	

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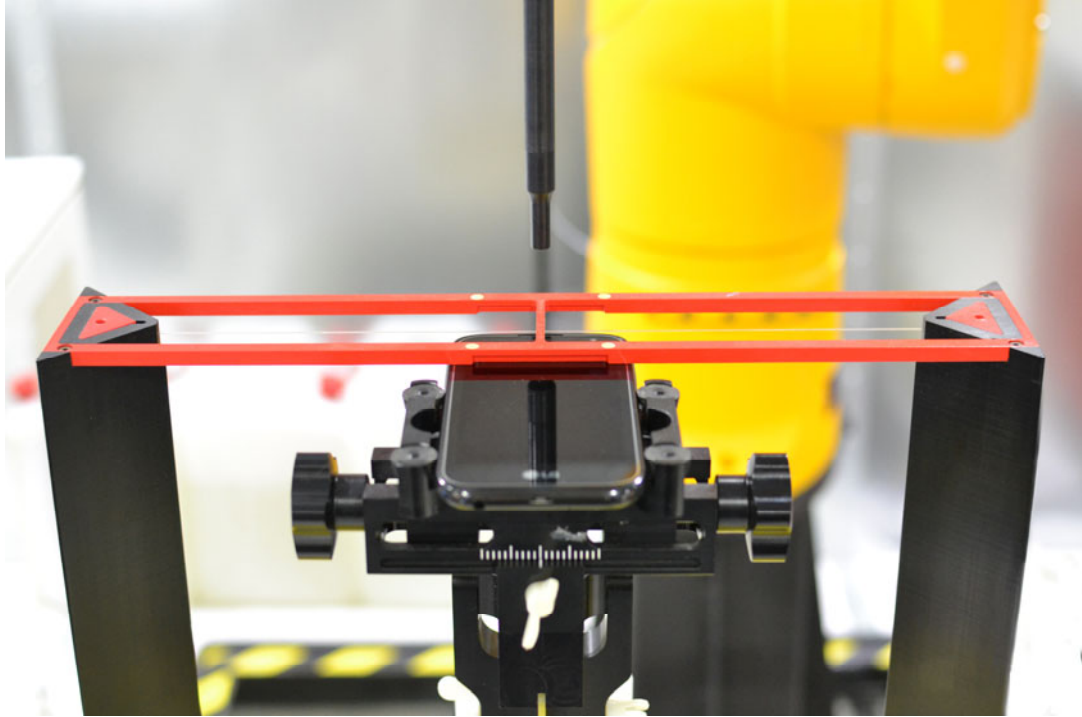


Figure 17-1
Ear Reference Point HAC Phantom Alignment

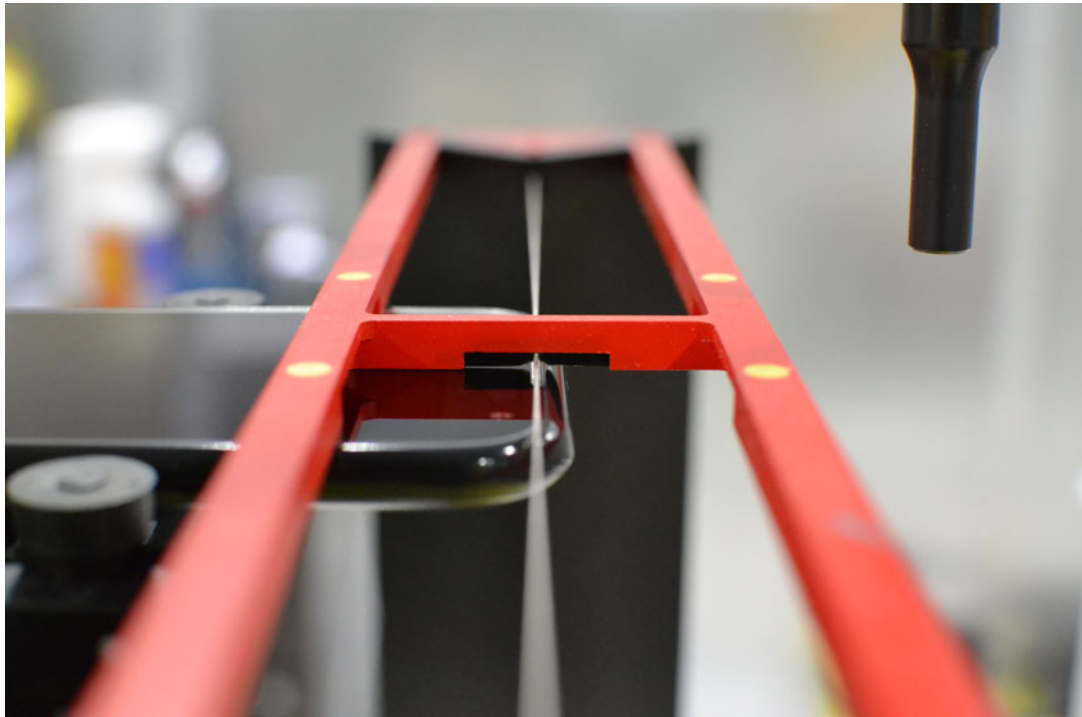




Figure 17-2
HAC Phantom Plane Alignment

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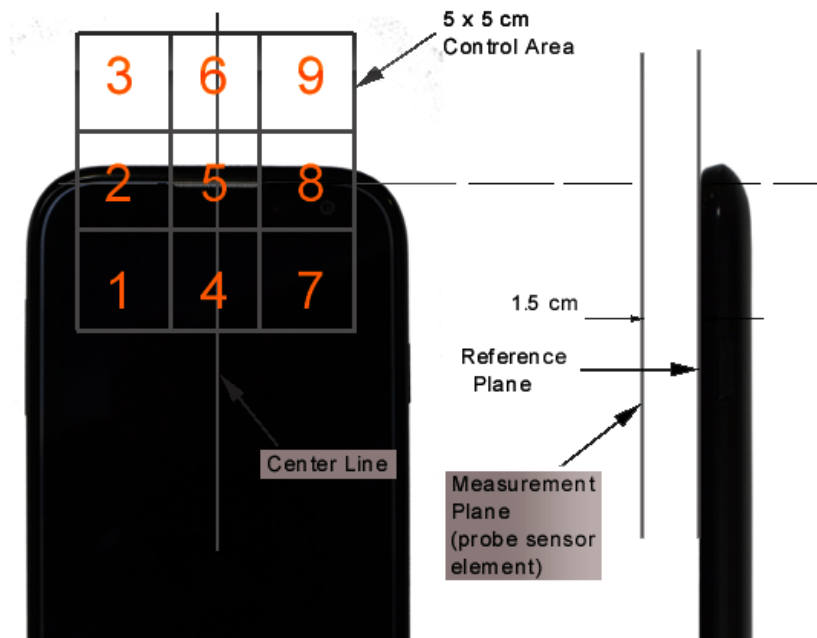




Figure 17-3 5x5 Scan grid above WD



Figure 17-4 E-Field WD Scan overlay

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